Notice of Allowability	Application No.	Applicant(s)
	10/666,574	HUNG ET AL.
	Examiner	Art Unit
	Gautam R. Patel	2627
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.		
1. This communication is responsive to		
2. The allowed claim(s) is/are <u>1-8</u> .		
 3.		
Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview Summary Paper No./Mail Dat 8), 7. ☐ Examiner's Amenda	ė

Art Unit: 2627

ALLOWANCE & REASON FOR ALLOWANCE

1. The following is an Examiner's Statement of Reasons for Allowance:

Claims 1-8 are allowable over the prior art of record since the cited references taken individually or in combination fails to particularly disclose a method for defect detecting having a low pass filter with first and also "second threshold frequency, second threshold frequency being higher than the first frequency and second upper limit is greater than the first upper limit". It is noted that the closest prior art, Ushio et al. (US patent 4,189,745) shows a similar apparatus which has low pass filter and is detecting defects in similar fashion. Also AAPA also detects the defects in a similar fashion. However Ushio and AAPA fails to disclose second frequency and second higher and lower thresholds as disclosed.

2. Any comments considered necessary by applicant must be submitted no later than the payment of the Issue Fee and, to avoid processing delays, should preferably accompany the Issue Fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Other prior art cited

- 3. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.
 - a. Ushio et al. (US. Patent 4189745) "Defect detecting apparatus".

Contact information

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Gautam R. Patel whose telephone number is 571-272-7625. The examiner can normally be reached on Monday through Thursday from 7:30 to 6.

The appropriate fax number for the organization (Group 2650) where this application or proceeding is assigned is 571-273-8300.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Mr. Dwayne Bost, who can be reached on (571) 272-7023.

Any inquiry of a general nature or relating to the status of this application should be directed to the Electronic Business Center whose telephone number is 866-217-9197 or the USPTO contact Center telephone number is (800) PTO-9199.

GAUTAM R. PATEL
PRIMARY EXAMINER

Gautam R. Patel Primary Examiner Group Art Unit 2627

May 26, 2006